

Notice of References Cited	Application/Control No. 10/714,642	Applicant(s)/Patent Under Reexamination TAKENAKA ET AL.	
	Examiner Tan Le	Art Unit 3632	Page 1 of 1

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*	D	US-2004/0124332	07-2004	Takenaka et al.	248/648
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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